

Search Notes

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Leon J. Harper

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Reexamination

KAWAI ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
707	200,104.1, 1, 10, 8, 6, 5, 4	3/2/2006	LJH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR